

<b>Search Notes</b> 	<b>Applicant/Country</b> 10/797,036 <b>Examiner</b> Lincoln Donovan	<b>Applicant(s)/Patent under Examination</b> WYETH ET AL. <b>Art Unit</b> 2832
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
same as above		1/31/2005	LD